

Notice of References Cited	Application/Control No. 10/501,737		Applicant(s)/Patent Under Reexamination KANNAN ET AL.	
	Examiner Dwan A. Gerido, Ph.D.		Art Unit 1797	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,716,477	04-2004	Komiyama et al.	427/8
*	B	US-5,569,837	10-1996	Hinaga, Yasushi	73/19.01
*	C	US-2003/0185966	10-2003	Kim et al.	427/8
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	K	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

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